

## Features

- 650V GaN enhancement-mode transistor
- Normally off design
- No  $Q_{rr}$  (reverse recovery charge)
- Low  $Q_g$  (gate charge), low  $Q_{oss}$  (output charge)
- Integrated ESD protection

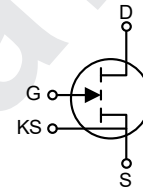
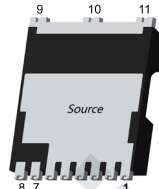
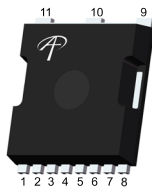
## Applications

- AC/DC and DC/DC converters, totem pole PFC, fast battery charging, high density and high efficiency power conversion

## Product Summary at $T_J = 25^\circ\text{C}$

$V_{DS, \max}$	650V
$R_{DS(on), \max} @ V_{GS} = 6V$	35m $\Omega$
$Q_{g, \text{typ}} @ V_{DS} = 400V$	14nC
$I_{D, \text{pulse}}$	127A
$Q_{oss} @ V_{DS} = 400V$	132nC
$Q_{rr} @ V_{DS} = 400V$	0nC

## Pin Configuration



## Pin Information

Gate	Drain	Kelvin Source	Source
8	9, 10, 11	7	1, 2, 3, 4, 5, 6

## Ordering Information

Ordering Part Number	Package Type	Form	Shipping Quantity
AOTL035V65GA1	TOLL	Tape and Reel	1500

Contact local sales office for full product datasheet.

## Absolute Maximum Ratings

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter		AOTL035V65GA1	Units
$V_{DS, \max}$	Drain Source Voltage	$V_{GS} = 0V$ , $T_J = -55^\circ\text{C}$ to $150^\circ\text{C}$	650	V
$V_{DS, \text{trans}}$	Drain Source Voltage Transient <sup>(1)</sup>	$V_{GS} = 0V$	800	
$V_{DS, \text{pulse}}$	Drain Source Voltage Pulsed <sup>(2)</sup>	$T_C = 25^\circ\text{C}$ , total time < 10 hours $T_C = 125^\circ\text{C}$ , total time < 1 hour	750	
$I_D$	Continuous Drain Current	$T_C = 25^\circ\text{C}$	64	A
		$T_C = 125^\circ\text{C}$	32	
$I_{D, \text{pulse}}$	Pulsed Drain Current <sup>(3)</sup>	$T_C = 25^\circ\text{C}$ , $V_{GS} = 6V$ , $t_{\text{pulse}} = 10\mu\text{s}$ $T_C = 125^\circ\text{C}$ , $V_{GS} = 6V$ , $t_{\text{pulse}} = 10\mu\text{s}$	127 64	
$V_{GS}$	Gate Source Voltage, Continuous <sup>(4)</sup>	$T_J = -55^\circ\text{C}$ to $150^\circ\text{C}$	-6 to 7	V

## Absolute Maximum Ratings (Continued)

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	AOTL035V65GA1	Units
$V_{GS, \text{pulse}}$	Gate Source Voltage, Pulsed $T_J = -55^\circ\text{C}$ to $150^\circ\text{C}$ , $t_{\text{pulse}} = 50\text{ns}$ , $f = 100\text{kHz}$ , open drain	-20 to 10	V
$P_{\text{tot}}$	Power Dissipation <sup>(5)</sup> $T_C = 25^\circ\text{C}$	367	W
$T_{J, \text{stg}}$	Junction and Storage Temperature Range	-55 to 150	$^\circ\text{C}$

## Thermal Characteristics

Symbol	Parameter	Typ	Max	Note	Units
$R_{\theta JA}$	Thermal Resistance Junction-to-Ambient <sup>(6)</sup>	56.1			$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction-to-Case	0.34			$^\circ\text{C/W}$
$T_{\text{sold}}$	Maximum Reflow Soldering Temperature	260		MSL3	$^\circ\text{C}$

## Electrical Characteristics

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units	
STATIC PARAMETERS							
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 67.4mA$	$T_J = 25^{\circ}C$	1.2	1.7	2.5	V
			$T_J = 150^{\circ}C$		1.6		
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS} = 650V$ , $V_{GS} = 0V$	$T_J = 25^{\circ}C$		11	143	$\mu A$
			$T_J = 150^{\circ}C$		29		
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS} = 6V$ , $V_{DS} = 0V$ , $T_J = 25^{\circ}C$			358		$\mu A$
$R_{DS(on)}$	Drain-Source On-State-Resistance	$V_{GS} = 6V$ , $I_D = 18A$	$T_J = 25^{\circ}C$		27	35	m $\Omega$
			$T_J = 150^{\circ}C$		62		
$R_G$	Gate Resistance	f = 5MHz; open drain			1.8		$\Omega$
DYNAMIC							
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ , $V_{DS} = 400V$ , f = 100kHz			488		pF
$C_{oss}$	Output Capacitance				153		
$C_{rss}$	Reverse Transfer Capacitance				2.67		
$C_{o(er)}$	Effective Output Capacitance Energy Related <sup>(7)</sup>	$V_{GS} = 0V$ , $V_{DS} = 0$ to 400V			279		pF
$C_{o(tr)}$	Effective Output Capacitance Time Related <sup>(8)</sup>				381		
$Q_{OSS}$	Output Charge				155		nC
SWITCHING							
$Q_G$	Gate Charge	$V_{GS} = 0$ to 6V, $V_{DS} = 400V$ , $I_D = 18A$			14		nC
$Q_{GS}$	Gate-Source Charge				1.1		
$Q_{GD}$	Gate-Drain Charge				5.8		
$V_{Plat}$	Gate Plateau Voltage	$V_{DS} = 400V$ , $I_D = 18A$			2.3		V

## Electrical Characteristics (Continued)

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

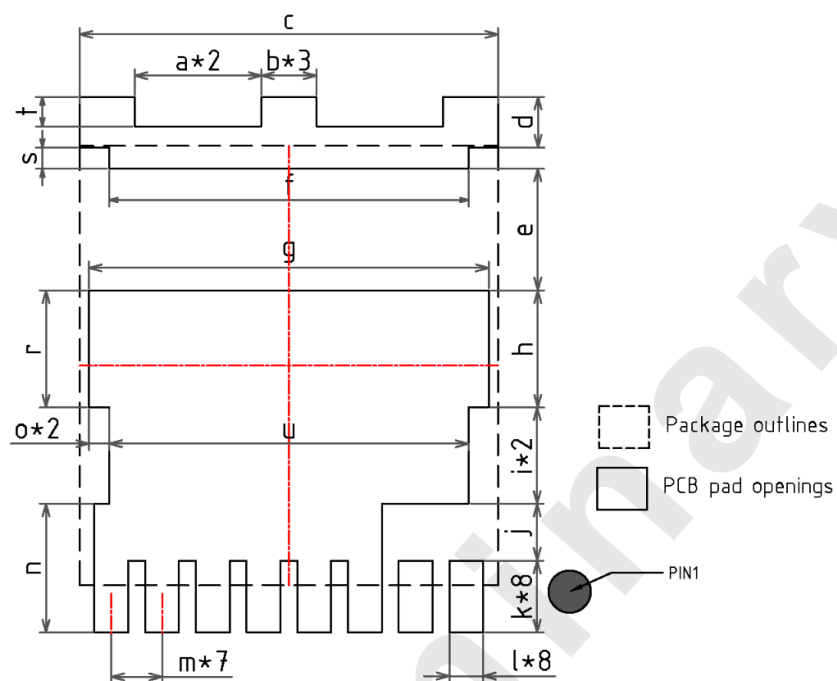
Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>REVERSE CONDUCTION</b>						
$V_{SD}$	Source-Drain Reverse Voltage	$V_{GS} = 0\text{V}, I_S = 18\text{A}$		2.3		V
$I_{S, \text{pulse}}$	Reverse Pulsed Current	$V_{GS} = 6\text{V}, t_{\text{pulse}} = 10\mu\text{s}$			127	A
$Q_{rr}$	Reverse Recovery Charge	$V_R = 400\text{V}, I_{SD} = 18\text{A}$		0		nC
$t_{rr}$	Reverse Recovery Time			0		ns
$I_{rrm}$	Peak Reverse Recovery Current			0		A

### Notes:

1.  $V_{DS, \text{transient}}$  is intended for non-repetitive events,  $t_{\text{PULSE}} < 200\mu\text{s}$ .
2.  $V_{DS, \text{pulse}}$  is intended for repetitive pulse,  $t_{\text{PULSE}} < 100\text{ns}$ .
3. Limit was extracted from characterization test, not measured during production.
4. The minimum  $V_{GS}$  is clamped by ESD protection circuit, as shown in Figure 8.
5. Power dissipation, and consequently max. current ratings are obtained

- using max. thermal resistance and max. temperature of  $150^\circ\text{C}$ .
6.  $R_{\theta JA}$  is determined with the device mounted on one square inch of copper pad, single layer 2oz copper on FR4 board.
7.  $C_{O(er)}$  is the fixed capacitance that gives the same stored energy as  $C_{OSS}$  while VDS is rising from 0 to 400V.
8.  $C_{O(tr)}$  is the fixed capacitance that gives the same charging time as  $C_{OSS}$  while VDS is rising from 0 to 400V.

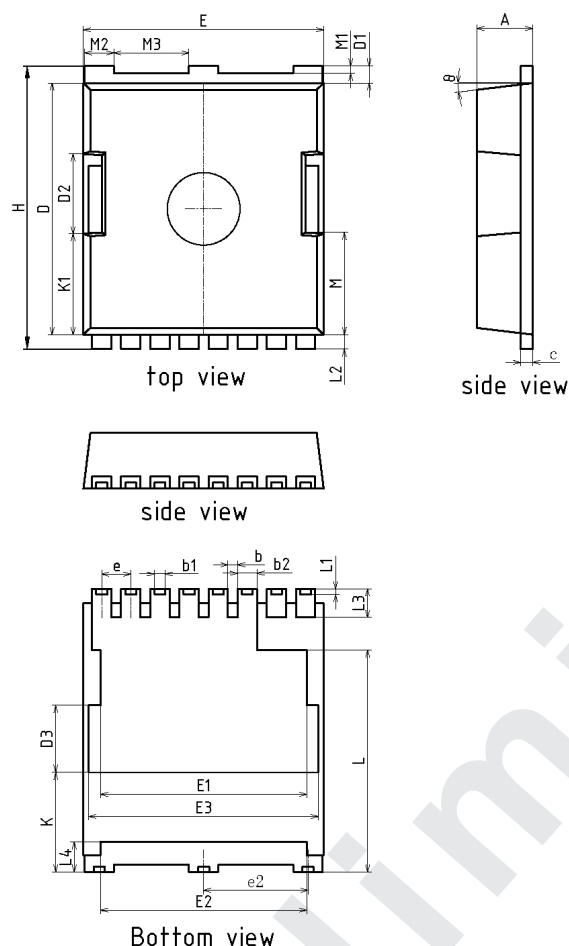
## Recommended PCB Footprint



SYMBOL	DIMENSION	SYMBOL	DIMENSION
a	3.00	k	1.70
b	1.30	l	0.80
c	9.90	m	1.20
d	1.20	n	3.05
e	2.88	o	0.48
f	8.50	r	2.77
g	9.46	s	0.50
h	2.77	t	0.70
i	2.28	u	8.50
j	1.35	/	/

Notes:  
 (1) All dimension are in millimeters.  
 (2) Drawing is not to scale.

## Package Dimensions, TOLL

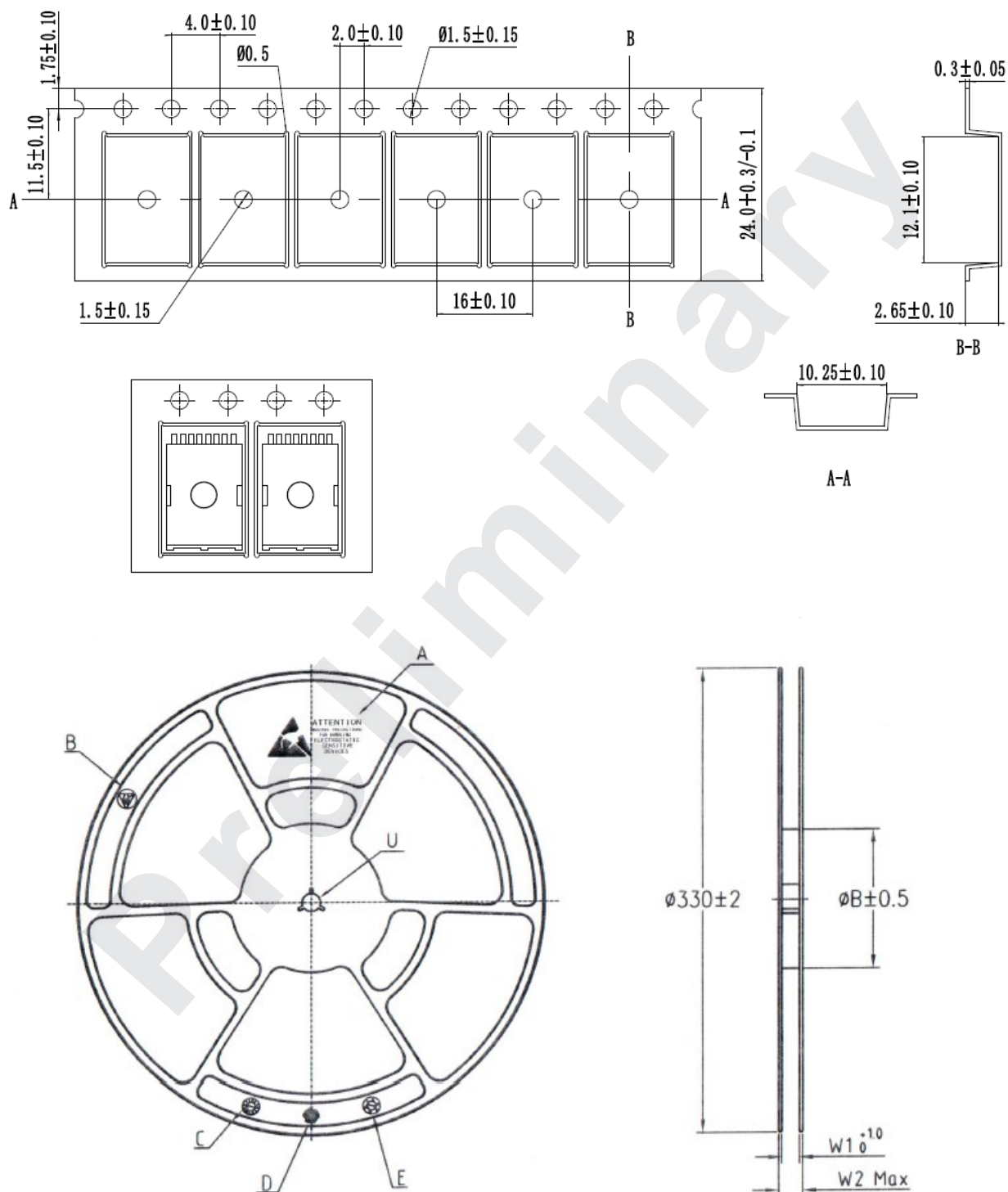


SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.15	2.30	2.45
b	0.30	0.40	0.50
b1	0.31	0.43	0.55
b2	0.65	0.80	0.90
c	0.40	0.50	0.60
D	10.18	10.38	10.58
D1	0.50	0.70	0.90
D2	3.30REF		
D3	2.77REF		
E	9.70	9.90	10.10
E1	8.50REF		
E2	8.50REF		
E3	9.46REF		
e	1.10	1.20	1.30
H	11.48	11.68	11.88
K	4.08REF		
K1	4.18REF		
L	9.13REF		
L1	0.23REF		
L2	0.50	0.60	0.70
L3	1.00	1.20	1.40
L4	1.00	1.20	1.40
M	4.18REF		
M1	0.26REF		
M2	1.10	1.20	1.30
M3	3.10REF		
Θ	10.00REF		
e2	4.20	4.30	4.40

### Notes:

- (1) Dimensioning and tolerancing confirm to ASME Y14.5M-1994
- (2) All dimensions are in millimeters, angles are in degrees
- (3) Coplanarity applies to the exposed heat slug as well as the terminal
- (4) Radius on terminal is optional
- (5) General tolerance:  $\pm 0.10$  mm

## Tape and Reel Dimensions, TOLL



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